

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/658,347	FUJIEDA, KENICHIRO	
Examiner	Art Unit	_
Gerald B. Klebe	3618	

SEARCHED								
Class	Subclass	Date	Examiner					
180	68.4 68.6 68.5 271 274	1 Junos	LY3X					
296	187.09 187.04							
296 B60R	21/34							

INT	ERFERENC	E SEARCH	IED
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
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